

PC922

High Power OPIC Photocoupler

* Lead forming type (I type) and taping reel type (P type) are also available. (PC922I/PC922P) (Page 656)

■ Features

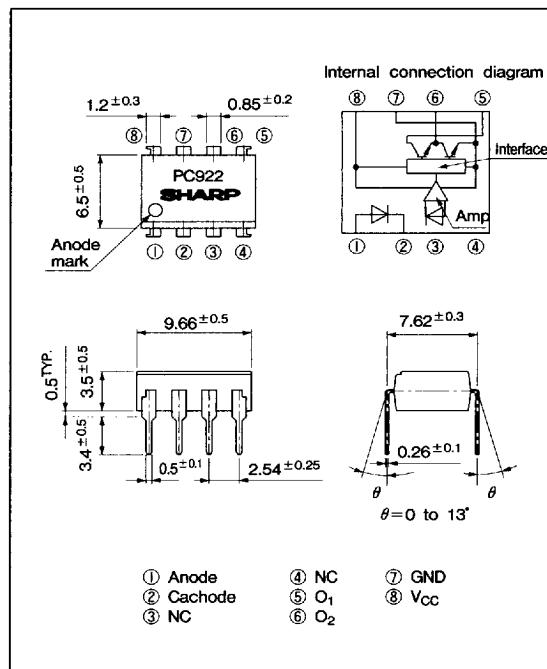
1. Built-in base amplifier for inverter drive
2. High power (I_{O1} : MAX. 0.5A(DC))
(I_{O2P} : MAX. 2.0A(pulse))
3. High isolation voltage between input and output (V_{iso} : 5 000V_{rms})
4. High noise reduction type
5. High speed response (t_{PHL}, t_{PLH} : MAX. 5 μ s)
6. High sensitivity (I_{FLH} : MAX. 3mA)
7. Recognized by UL, file No. E64380

■ Applications

1. Inverter controlled air conditioners
2. Small capacitance general purpose inverters

■ Outline Dimensions

(Unit : mm)



* "OPIC" (Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.

■ Absolute Maximum Ratings (Ta = T_{opr} unless otherwise specified)

	Parameter	Symbol	Rating	Unit
Input	Forward current	I _F	25	mA
	* ¹ Reverse voltage	V _R	6	V
Output	Supply voltage	V _{CC}	18	V
	O ₁ output current	I _{O1}	0.5	A
	* ² O ₁ peak output current	I _{O1P}	1.0	A
	O ₂ output current	I _{O2}	0.6	A
	* ² O ₂ peak output current	I _{O2P}	2.0	A
	O ₁ output voltage	V _{O1}	18	V
	Power dissipation	P _O	500	mW
	Total power dissipation	P _{tot}	550	mW
	* ³ Isolation voltage	V _{iso}	5 000	V _{rms}
	Operating temperature	T _{opr}	-20 to +80	°C
	Storage temperature	T _{stg}	-55 to +125	°C
	* ⁴ Soldering temperature	T _{sol}	260	°C

*1 Ta = 25°C

*2 Pulse width ≤ 5 μ s, Duty ratio = 0.01

*3 40 to 60%RH, AC for 1 minute,
Ta = 25°C

*4 For 10 seconds

8180798 0011832 T73

■ Electro-optical Characteristics(Ta = T_{opr} unless otherwise specified)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	Fig.	
Input	V _{F1}	T _a =25°C, I _F =5mA	—	1.1	1.4	V	—	
	V _{F2}	T _a =25°C, I _F =0.2mA	0.6	0.9	—	V	—	
	I _R	T _a =25°C, V _R =3V	—	—	10	μA	—	
	C _t	T _a =25°C, V=0, f=1kHz	—	30	250	pF	—	
Output	Operating supply voltage	V _{CC}	—	5.4	—	13	V	—
	O ₁ low level output voltage	V _{O1L}	V _{CC} =6V, I _{O2} =0.4A, R _{L2} =10Ω, I _F =5mA	—	0.2	0.4	V	1
	O ₂ high level output voltage	V _{O2H}	V _{CC} =6V, I _{O2} =-0.4A, I _F =5mA	4.5	5.0	—	V	2
	O ₂ low level output voltage	V _{O2L}	V _{CC} =6V, I _{O2} =0.5A, I _F =0	—	0.2	0.4	V	—
	O ₁ leak current	I _{O1L}	V _{CC} =13V, I _F =0	—	—	200	μA	3
	O ₂ leak current	I _{O2L}	V _{CC} =13V, I _F =5mA	—	—	200	μA	4
	High level supply current	I _{CH}	T _a =25°C, V _{CC} =6V, I _F =5mA	—	9	13	mA	—
			V _{CC} =6V, I _F =5mA	—	—	17	mA	—
	Low level supply current	I _{CL}	T _a =25°C, V _{CC} =6V, I _F =0	—	11	15	mA	—
			V _{CC} =6V, I _F =0	—	—	20	mA	—
Transfer characteristics	*5 "Low→High" threshold input current	I _{FLH}	T _a =25°C, V _{CC} =6V, R _{L1} =5Ω, R _{L2} =10Ω	0.3	1.5	3.0	mA	5
			V _{CC} =6V, R _{L1} =5Ω R _{L2} =10Ω	0.2	—	5.0	mA	5
	Isolation resistance	R _{ISO}	T _a =25°C, DC=500V 40 to 60%RH	5×10 ¹⁰	10 ¹¹	—	Ω	—
	"Low→High" propagation delay time	t _{PLH}	T _a =25°C, V _{CC} =6V I _F =5mA R _{L1} =5Ω R _{L2} =10Ω	—	2	5	μs	6
	"High→Low" propagation delay time	t _{PHL}		—	2	5	μs	
	Rise time	t _r		—	0.2	1	μs	
	Fall time	t _f		—	0.1	1	μs	
	Instantaneous common mode rejection voltage "Output : High level"	C _{MH}	T _a =25°C, V _{CM} =600V _(peak) I _F =5mA, R _{L1} =470Ω, R _{L2} =1kΩ, ΔV _{O2H} =0.5V	-1 500	—	—	V/μs	7
	Instantaneous common mode rejection voltage "Output : Low level"	C _{ML}	T _a =25°C, V _{CM} =600V _(peak) I _F =0, R _{L1} =470Ω, R _{L2} =1kΩ, ΔV _{O2L} =0.5V	1 500	—	—	V/μs	7

*5 I_{FLH} represents forward current when output goes from low to high.**■ Truth Table**

Input	O ₂ Output	Tr. 1	Tr. 2
ON	High level	ON	OFF
OFF	Low level	OFF	ON

■ Test Circuit

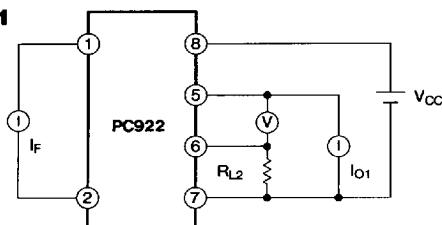
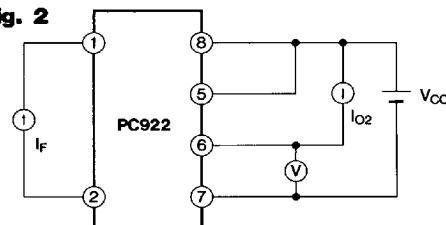
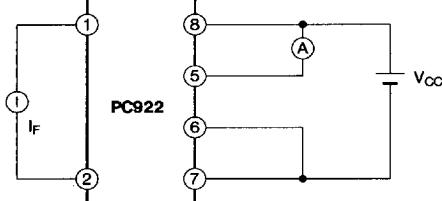
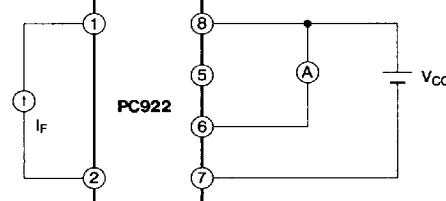
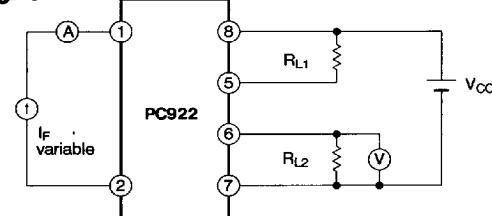
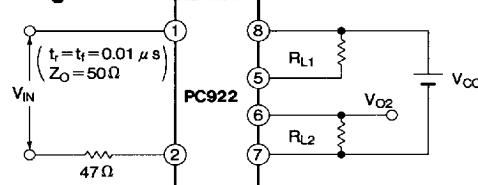
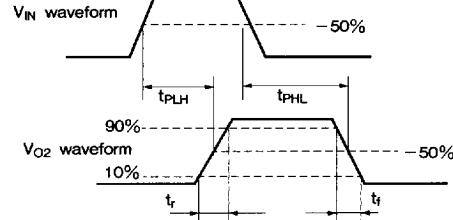
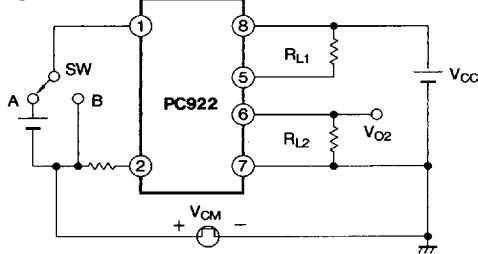
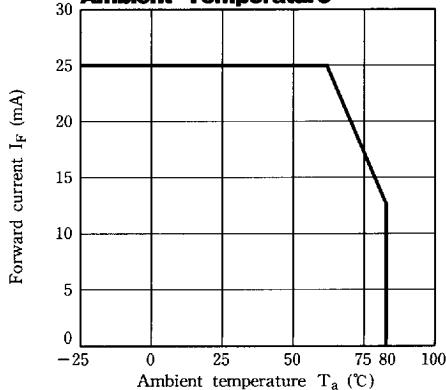
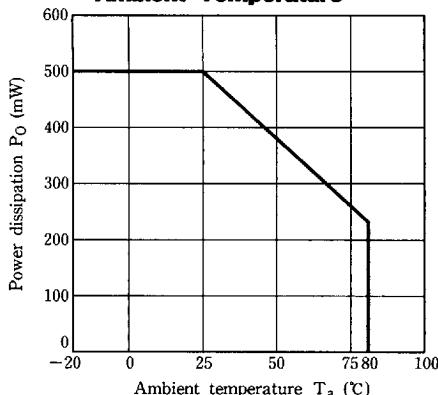
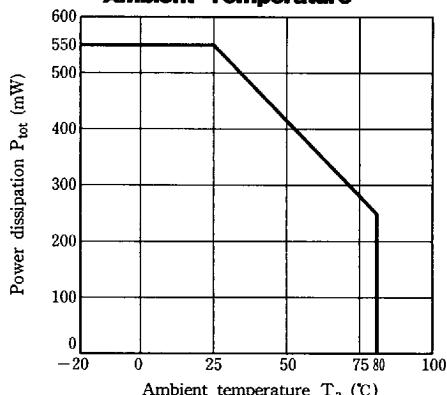
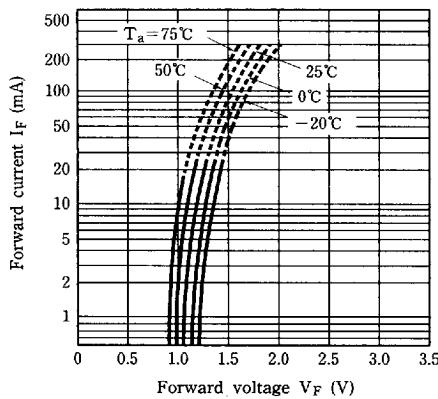
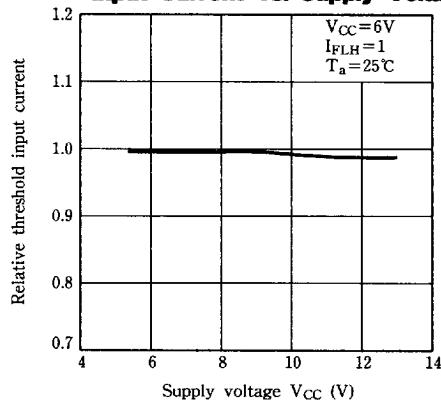
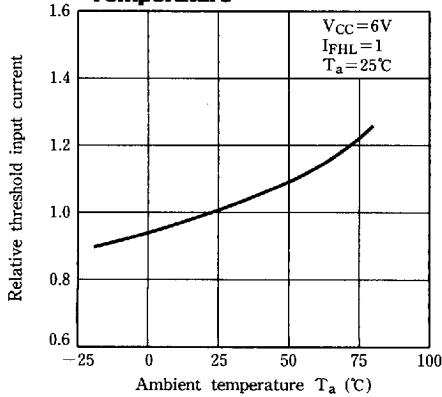
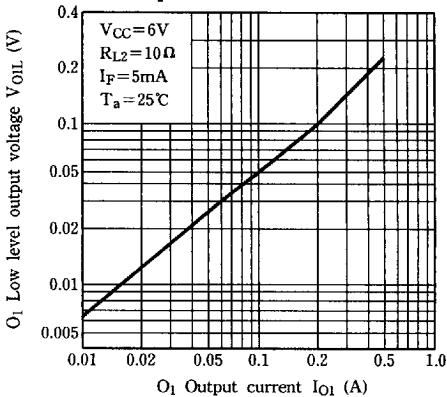
Fig. 1**Fig. 2****Fig. 3****Fig. 4****Fig. 5****Fig. 6****Fig. 7****Fig. 8 Forward Current vs. Ambient Temperature**

Fig. 9-a Power Dissipation vs. Ambient Temperature**Fig. 9-b Power Dissipation vs. Ambient Temperature****Fig. 10 Forward Current vs. Forward Voltage****Fig.11 "Low→High" Relative Threshold Input Current vs. Supply Voltage****Fig.12 "Low→High" Relative Threshold Input Current vs. Ambient Temperature****Fig.13 O₁ Low Level Output Voltage vs. O₁ Output Current**

■ 8180798 0011835 782 ■

Fig.14 O₁ Low Level Output Voltage vs. Ambient Temperature

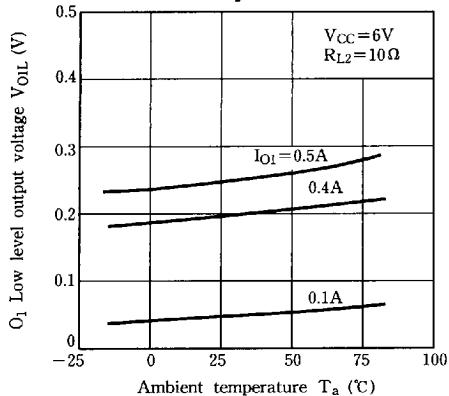


Fig.16 O₂ High Level Output Voltage vs. Ambient Temperature

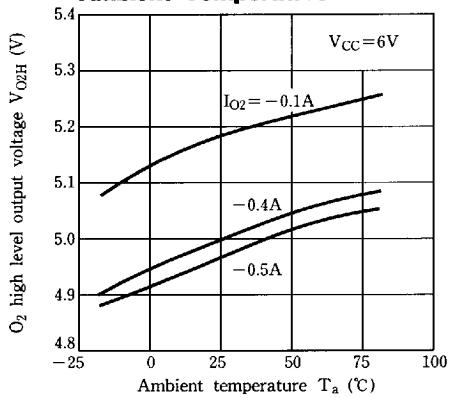


Fig.18 O₂ Low Level Output Voltage vs. Ambient Temperature

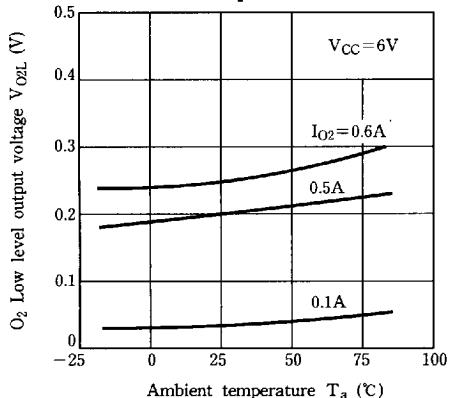


Fig.15 O₂ High Level Output Voltage vs. O₂ Output Current

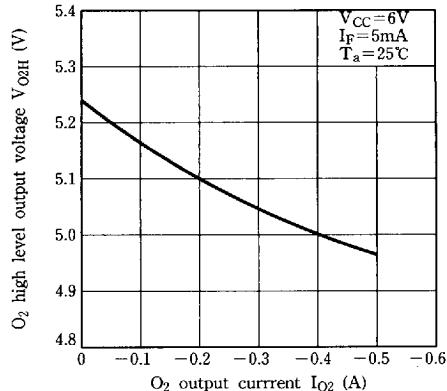


Fig.17 O₂ Low Level Output Voltage vs. O₂ Output Current

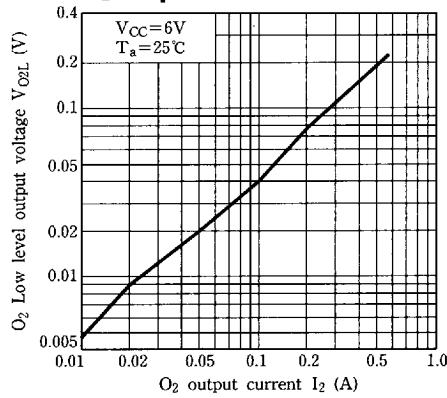


Fig.19 High Level Supply Current vs. Supply Voltage

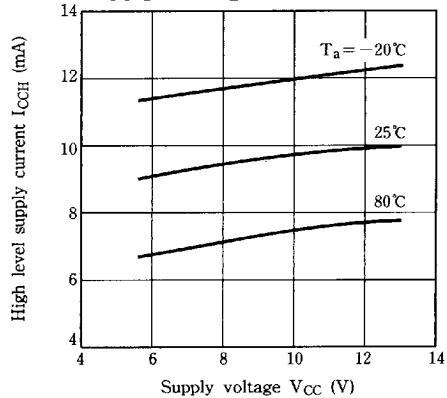


Fig.20 Low Level Supply Current vs. Supply Voltage

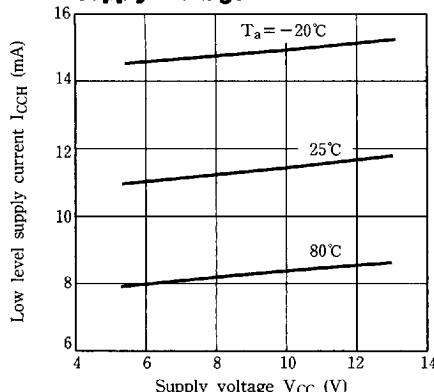


Fig.21 Propagation Delay Time vs. Forward Current

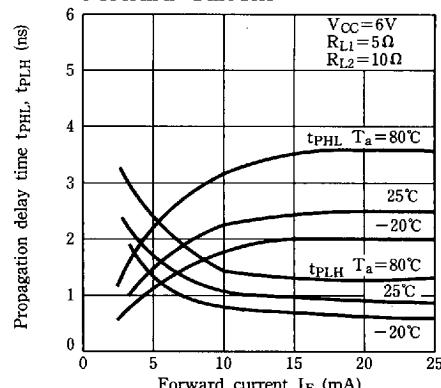


Fig.22 Propagation Delay Time vs. Ambient Temperature

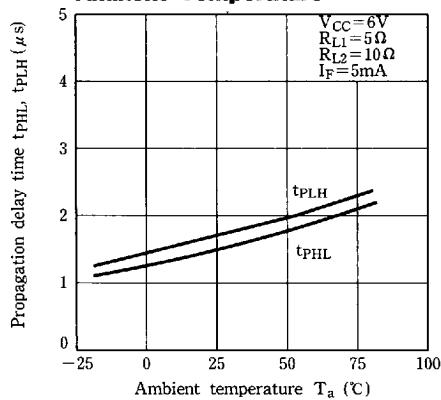
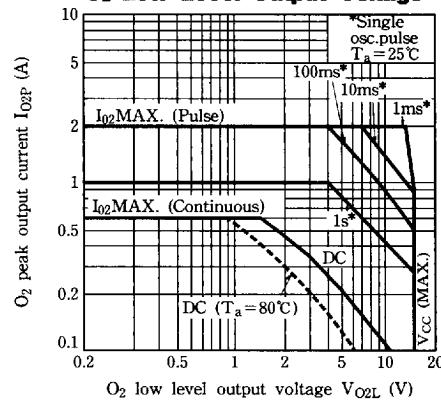
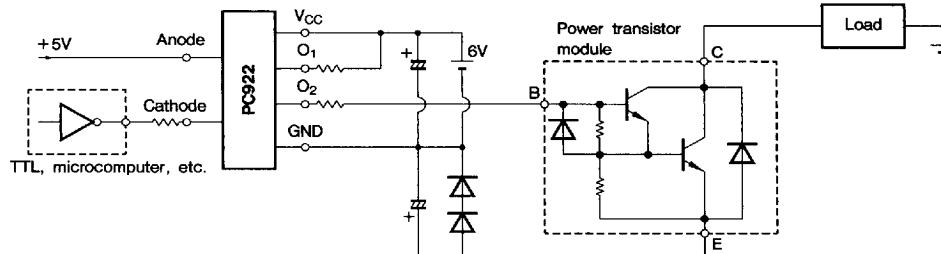


Fig.23 O₂ Peak Output Current vs. O₂ Low Level Output Voltage



■ Application Circuit



■ Precautions for Use

- (1) It is recommended that a by-pass capacitor of more than $0.01 \mu\text{F}$ is added between V_{CC} and GND near the device in order to stabilize power supply line.
- (2) Handle this product the same as with other integrated circuits against static electricity.
- (3) As for other general cautions, refer to the chapter "Precautions for Use".(Page 78 to 93)

■ 8180798 0011837 555 ■